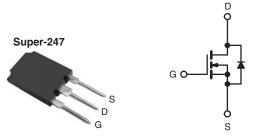


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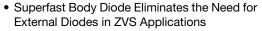
Power MOSFET

PRODUCT SUMMARY							
V _{DS} (V)	600	600					
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	V _{GS} = 10 V 0.12					
Q _g (Max.) (nC)	320	320					
Q _{gs} (nC)	85	85					
Q _{gd} (nC)	160	160					
Configuration	Single	Single					



N-Channel MOSFET

FEATURES





• Lower Gate Charge Results in Simple Drive Requirements



- Enhanced dV/dt Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise **Immunity**
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uniterruptible Power Supplies
- Motor Control applications

ORDERING INFORMATION			
Package	Super-247		
Load (Dh) frag	IRFPS38N60LPbF		
Lead (Pb)-free	SiHFPS38N60L-E3		
SnPb	IRFPS38N60L		
ו אורט	SiHFPS38N60L		

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	600	V	
Gate-Source Voltage			V_{GS}	± 30	7 v	
Continuous Drain Current	V at 10 V	T _C = 25 °C		38		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	ID	24	A	
Pulsed Drain Current ^a			I _{DM}	150		
Linear Derating Factor				4.3	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	680	mJ	
Repetitive Avalanche Current ^a			I _{AR}	38	А	
Repetitive Avalanche Energy ^a			E _{AR}	54	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P _D	540	W	
Peak Diode Recovery dV/dtc			dV/dt	19	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d		
Mounting Torque	6 22 or I	0.00 - 140		10	lbf ⋅ in	
Mounting Torque	6-32 or M3 screw			1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 12). b. Starting T_J = 25 °C, L = 0.91 mH, R_g = 25 Ω , I_{AS} = 38 A, dV/dt = 13 V/ns (see fig. 14a). c. I_{SD} \leq 38 A, dI/dt \leq 630 A/µs, V_{DD} \leq V_{DS}, T_J \leq 150 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFPS38N60L, SiHFPS38N60L

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	40		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.22		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0 V, I _D = 250 μA	600	-	_	V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J		ce to 25 °C, I _D = 1 mA	-	410	-	mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} :	= V _{GS} , I _D = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 30 V	-	-	± 100	nA
		V _{DS} = 600 V, V _{GS} = 0 V		-	-	50	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 480 \	V, V _{GS} = 0 V, T _J = 125 °C	-	-	2.0	mA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 23 A ^b	-	0.12	0.15	Ω
Forward Transconductance	9 _{fs}	V_{DS}	= 50 V, I _D = 23 A ^b	20	-	-	S
Dynamic				1			
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	7990	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 V$,	-	740	-	
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	72	-	pF
Effective Output Capacitance	C _{oss} eff.		V 0 V	-	350	-	Pi
Effective Output Capacitance (Energy Related)	C _{oss} eff. (ER)	$V_{GS} = 0 \text{ V}$ $V_{DS} = 0 \text{ V to } 480 \text{ V}^{c}$		-	260	-	
Total Gate Charge	Q_g			-	-	320	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 \text{ V}$ $I_D = 38 \text{ A}, V_{DS} = 480 \text{ V}$		-	-	85	nC
Gate-Drain Charge	Q_{gd}		see fig. 7 and 15 ^b		-	160	
Gate Resistance	R_{G}	f = 1 MHz, open drain		-	1.2	-	Ω
Turn-On Delay Time	t _{d(on)}	V _{DD} = 300 V, I _D = 38 A,		-	44	-	
Rise Time	t _r			-	130	-	
Turn-Off Delay Time	t _{d(off)}	$R_G = 4.3 \Omega, V_{GS} = 10 V,$		-	92	-	ns
Fall Time	t _f	see fig. 11a and 11b ^b		-	69	-	
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	38	^
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	150	A
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 38 A, V _{GS} = 0 V ^b		-	-	1.5	V
D D T	t _{rr}	T _J = 25 °C, I _F = 38 A		-	170	250	ns
Body Diode Reverse Recovery Time		T _J = 125 °C, dl/dt = 100 A/μs ^b		-	420	630	
B B' B B G'	Q _{rr}	T _J = 25 °C, I _F = 38 A, V _{GS} = 0 V ^b		-	830	1240	_
Body Diode Reverse Recovery Charge		T _J = 125 °C, dl/dt = 100 A/μs ^b		-	2600	3900	nC
D	1	T _J = 25 °C			9.1	14	Α
Reverse Recovery Time	I _{RRM}		11 = 23 0	-	9.1	14	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 12).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising form 0 % to 80 % V_{DS} . C_{oss} eff. (ER) is a fixed capacitance that stores the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

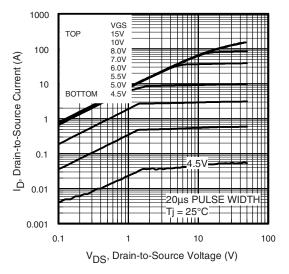


Fig. 1 - Typical Output Characteristics

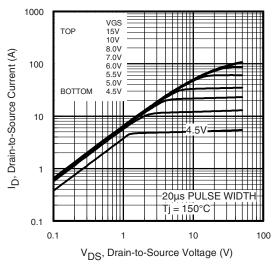


Fig. 2 - Typical Output Characteristics

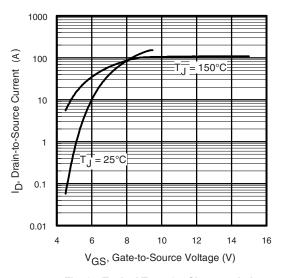


Fig. 3 - Typical Transfer Characteristics

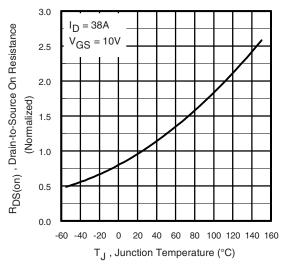


Fig. 4 - Normalized On-Resistance vs. Temperature

IRFPS38N60L, SiHFPS38N60L

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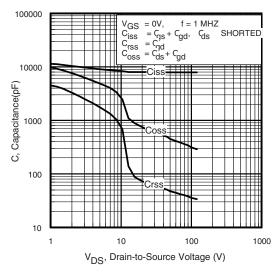


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

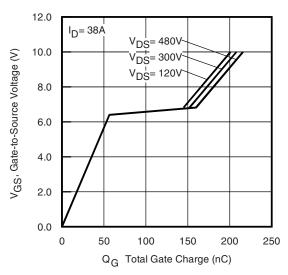


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

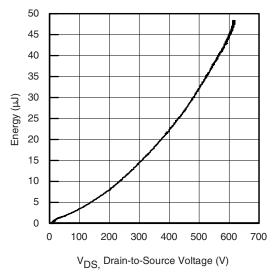


Fig. 6 - Typical Output Capacitance Stored Energy vs. \mathbf{V}_{DS}

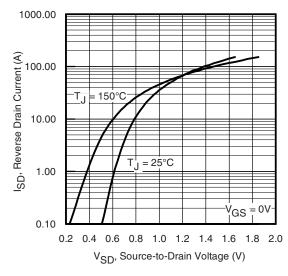


Fig. 8 - Typical Source-Drain Diode Forward Voltage



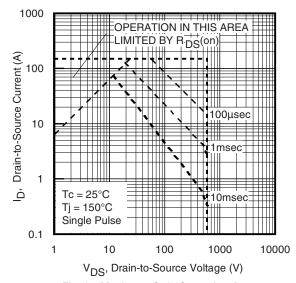


Fig. 9 - Maximum Safe Operating Area

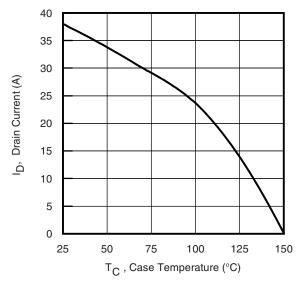


Fig. 10 - Maximum Drain Current vs. Case Temperature

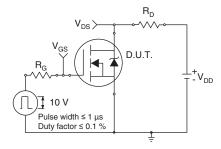


Fig. 11a - Switching Time Test Circuit

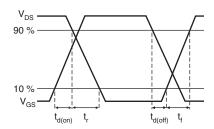


Fig. 11b - Switching Time Waveforms

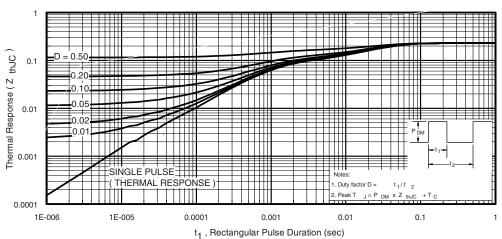


Fig. 12 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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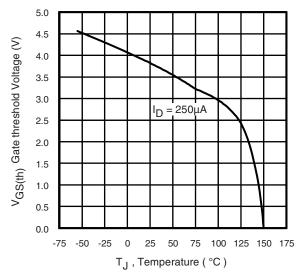


Fig. 13 - Threshold Voltage vs. Temperature

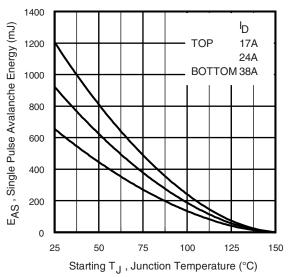


Fig. 14a - Maximum Avalanche Energy vs. Drain Current

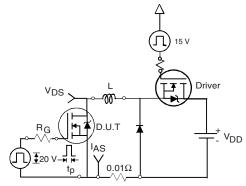


Fig. 14b - Unclamped Inductive Test Circuit

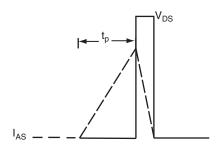


Fig. 14c - Unclamped Inductive Waveforms

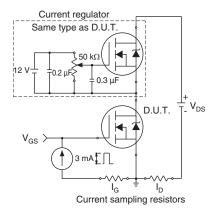


Fig. 15a - Basic Gate Charge Waveform

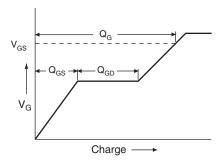
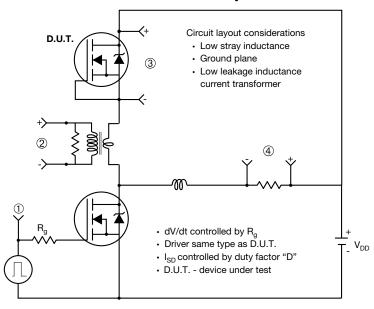


Fig. 15b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



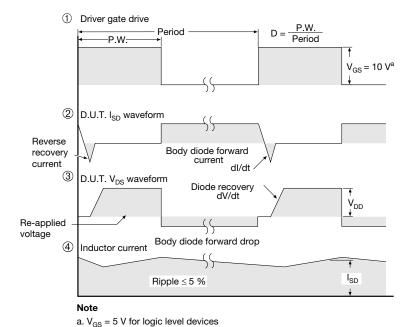


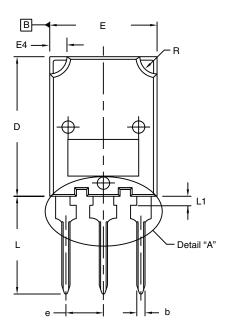
Fig. 16 - For N-Channel

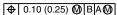
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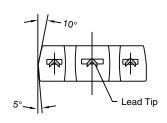


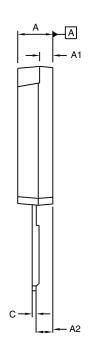


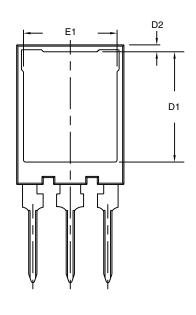
TO-274AA (HIGH VOLTAGE)

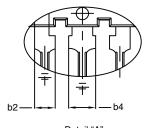












Detail "A" Scale: 2:1

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.70	5.30	0.185	0.209
A1	1.50	2.50	0.059	0.098
A2	2.25	2.65	0.089	0.104
b	1.30	1.60	0.051	0.063
b2	1.80	2.20	0.071	0.087
b4	3.00	3.25	0.118	0.128
С	0.80	1.20	0.031	0.047
D	19.80	20.80	0.780	0.819

MILLIMETERS		INC	HES
MIN.	MAX.	MIN.	MAX.
15.50	16.10	0.610	0.634
0.70	1.30	0.028	0.051
15.10	16.10	0.594	0.634
13.30	13.90	0.524	0.547
5.45	BSC	0.215 BSC	
13.70	14.70	0.539	0.579
1.00	1.60	0.039	0.063
2.00	3.00	0.079	0.118
	MIN. 15.50 0.70 15.10 13.30 5.45 13.70 1.00	MIN. MAX. 15.50 16.10 0.70 1.30 15.10 16.10 13.30 13.90 5.45 BSC 13.70 14.70 1.00 1.60	MIN. MAX. MIN. 15.50 16.10 0.610 0.70 1.30 0.028 15.10 16.10 0.594 13.30 13.90 0.524 5.45 BSC 0.215 13.70 14.70 0.539 1.00 1.60 0.039

ECN: S-82247-Rev. A, 06-Oct-08

DWG: 5975

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outer extremes of the plastic body.
- 3. Outline conforms to JEDEC outline to TO-274AA.

Document Number: 91365 Revision: 06-Oct-08



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